



## Model 325-FF-02 series Bare Die (Flip chip form, Au Pad)

## **Typical Optical-Electrical Characteristics**

 $(I_{F}=20mA, T_{a}=25^{\circ}C)$ 

| ltem                       | Symbol         | Unit | 325-FF-02-C |     |     |
|----------------------------|----------------|------|-------------|-----|-----|
|                            |                |      | Min         | Тур | Max |
| Peak Wavelength            | λ <sub>ρ</sub> | nm   | 320         | 325 | 330 |
| Radiant Flux               | Po             | mW   | -           | 3.5 | -   |
| Full Width at Half Maximum | ⊿λ             | nm   | -           | 13  | -   |
| Forward Voltage            | V <sub>F</sub> | V    | -           | 4.9 | -   |

(\*)Peak Wavelength Measurement tolerance is ±3nm.

(\*\*)Radiant Flux Measurement tolerance is ±10%.

Binning is available.

Specification and dimension are subject to change for improvement without notice.

#### $(I_F = 50 \text{mA}, T_a = 25^{\circ}\text{C})$

| ltem                       | Symbol         | Unit | 325-FF-02-C |     |     |
|----------------------------|----------------|------|-------------|-----|-----|
|                            |                |      | Min         | Тур | Max |
| Peak Wavelength            | λ <sub>p</sub> | nm   | 320         | 325 | 330 |
| Radiant Flux               | Po             | mW   | -           | 8.7 | -   |
| Full Width at Half Maximum | ⊿λ             | nm   | -           | 13  | -   |
| Forward Voltage            | V <sub>F</sub> | V    | -           | 5.2 | -   |

(\*)Peak Wavelength Measurement tolerance is ±3nm.

(\*\*)Radiant Flux Measurement tolerance is ±10%.

Binning is available.

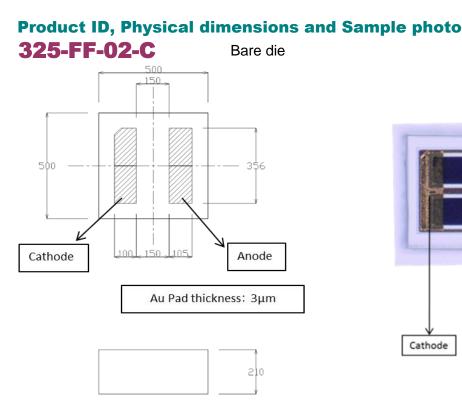
Specification and dimension are subject to change for improvement without notice.

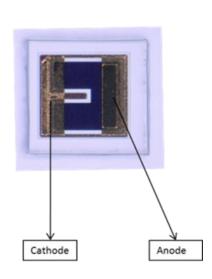




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**TENTATIVE** 

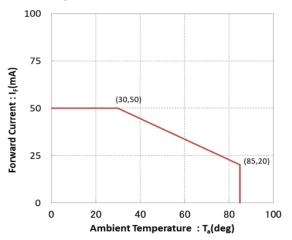




## **Absolute Maximum Ratings**

| ltem                  | Symbol           | Unit | Value                            |
|-----------------------|------------------|------|----------------------------------|
| Forward Current       | I <sub>F</sub>   | mA   | 50                               |
| Junction Temperature  | TJ               | °C   | 90                               |
| Operating Temperature | T <sub>OPR</sub> | °C   | -30 ~ +85                        |
| Storage Temperature   | T <sub>STR</sub> | °C   | -40 $\sim$ +85 (No condensation) |

#### **Derating Curve**



Notes:

Maximum ratings and derating curve strongly depend on assembly materials.

The above ratings and derating curve were determined using AIN submount ,AI substrate and heatsink. Ratings may be different for other materials and environment.

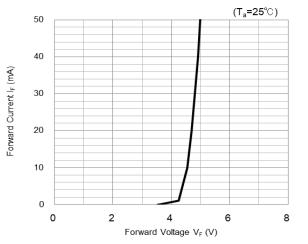


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### **Reference Data**

**Forward Voltage vs Forward Current** 



#### **Forward Current vs Radiated Flux** (T<sub>a</sub>=25℃) 250 200 Relative Radiant Flux (%) 150 100 50 0 0 10 20 30 40 50 Forward Current I<sub>F</sub> (mA)

## Spectrum

